Drage 2827

Docket No.: MAS-FIN-200

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as First Class Mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Nexandria, VA 22313-1450, on the date indicated below.

Date: march 8, 2004

THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applic. No.

10/010.164

Confirmation No: 7203

Applicant Filed

Simon Muff et al. November 13, 2001

Title

IC Chip

Art Unit

2827

Examiner

James M. Mitchell

Docket No.

MAS-FIN-200

Customer No.:

24131

## <u>INFORMATION DISCLOSURE STATEMENT</u> <u>UNDER 37 C.F.R. 1.97(C)(1)</u>

Hon. Commissioner for Patents

Sir:

In accordance with 37 C.F.R. 1.98 copies of the following patents and/or publications are submitted herewith:

Japanese patent Application JP 63 267 598 (Matsubara et al.), dated November 4, 1988.

In accordance with 37 C.F.R. 1.97(e) the undersigned herewith states that each item of information contained in the information disclosure statement was first cited in a communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of the information disclosure statement.

If no translation of pertinent portions of any foreign language patents or publications mentioned above is included with the aforementioned copies of those applications, patents and/or publications, it is because no existing translation is readily available to the applicant.

In accordance with 37 C.F.R. 1.97 (c) (1), consideration of this Information Disclosure Statement is requested.

Respectfully submitted,

Gregory L. Mayback Reg. No. 40,719

Date: March 8, 2004

Lerner And Greenberg, P.A. Post Office Box 2480 Hollywood, FL 33022-2480

Tel: (954) 925-1100 Fax: (954) 925-1101

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	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Attorney Docket No.: A		Sheet 1 of 1 Applic. No. 10/010,164	
ATEN E					Applicant Simon Muff et al.  Filing Date November 13, 2001  Simon Muff et al.  Group Art Unit 2827			
<u>:</u>	U.S. PATENT DOCUMENTS							
	EXAMINER INITIALS		PATENT NO.	DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE
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	FOREIGN PATENT DOCUMENT							
•			DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSL. YES   NO
		J	63 267 598	11/04/88	Japan			X
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	OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.